

<b>Notice of References Cited</b>	Application/Control No. 10/714,180	Applicant(s)/Patent Under Reexamination RIEKE ET AL.	
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*	B	US-6,803,138 B2	10-2004	Seabaugh et al.	429/30
*	C	US-6,893,762 B2	05-2005	Sarkar et al.	429/31
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**NON-PATENT DOCUMENTS**

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